Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,062	CROMER ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

SEARCHED				
Class	Subclass	Date	Examiner	
713	193	6/7/2007	ECT	
713	189	6/7/2007	ECT	
713	191	6/7/2007	ECT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	:			

SEARCH NOT (INCLUDING SEARCH		)
·	DATE	EXMR
USPTO, USPG, EPO, DERWENT, IBM TECH DES	6/7/2007	ECT
NPL - IEEE XPLORE	6/7/2007	ECT
INVENTOR SEARCH - PALM	6/7/2007	ECT
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTIONS	6/7/2007	ECT